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V.S. Department of Commerce Rev. 10/95 Patent and Trademark Office		10/688,575
	Filing Date	October 16, 2003
TRANSMITTAL FORM	First Named Inventor	J. Elon Graves
(to be used for all correspondence during pendency of filed application)	Group Art Unit Number	Not yet known
	Examiner Name	Not yet known
Total Number of Pages in This Submission 6 *	Attorney Docket Number	23236-07284
ENCLOSURES	(check all that appl	y)
Response to Notice to File Missing Parts Assignment & Recordation Cover Sheet Declaration Power of Attorney Application Data Sheet Information Disclosure Statement & PTO/SB/08A Copies of IDS Cited References Request for Corrected Filing Receipt Request for Correction of Recorded Assignment Amendment/Response: [ ] Page(s)	Appeal Commur Interferences Appeal Commur (Appeal Notice, Certified Copy o	(s): s) of Figure(s) [ ] nication to Board of Appeals and nication to Group Brief, Reply Brief) f Priority Document(s) Communication to Group
Signature:  Attorney/Reg. No.: Michael W. Farn, Reg. No. 41,0	ATTORNEY OR AGE	
		Dated: December 30, 2
I hereby certify that this correspondence, including the enclosure first class mail in an envelope addressed to: Commissioner for P If the Express Mail Mailing Number is filled in below, then this co "Express Mail Post Office to Addressee" service pursuant to 37 (	atents, P.O. Box 1450, Alexandria rrespondence is being deposited v	a, VA 22313-1450 on the date shown bel
Signature: Webael W		
Typed or Printed Name: Michael W. Farn		Dated: December 30, 2

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LIN THE UNITED STATES PATENT AND TRADEMARK OFFICE

APPLICANT:

J. Elon Graves, Malcolm J. Northcott and J. Christopher Shelton

APPLICATION NO.:

10/688,575

FILING DATE:

October 16, 2003

TITLE:

Combined Wavefront Sensor and Data Detector for a Free Space

Optical Communications System with Adaptive Optics

**EXAMINER:** 

Not yet known

GROUP ART UNIT:

Not yet known

ATTY. DKT. NO.:

23236-07284

## **CERTIFICATE OF MAILING**

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to: Commissioner For Patents, P.O. Box 1450, Alexandri VA 22313-1450, on the date shown below:

Dated: December

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y: Michael W. Farn, Reg. No. 41,015

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## INFORMATION DISCLOSURE STATEMENT Under 37 CFR §§ 1.56 and 1.97-98

SIR:

Pursuant to the provisions of 37 CFR §§ 1.56 and 1.97-98, enclosed herewith is modified form PTO/SB/08A listing references for consideration by the Examiner. Enclosed is a copy of each listed reference, which is not a U.S. Patent Document, that may be material to the examination of this application, and for which there may be a duty to disclose.

The filing of this Information Disclosure Statement shall not be construed as a representation regarding the completeness of the list of references, or that inclusion of a reference in this list is an admission that it is prior art or is pertinent to this application, or that a search has been made, or as an admission that the information listed is, or may be considered to be, material to patentability, or that no other material information exists, and shall not be construed as an admission against interest in any manner.

This Information Disclosure Statement is being filed:

within three months of the filing date of the application, or date of entry into the national stage of an international application, or before the mailing date of a first office action on the merits, whichever event last occurred;

before	the ma	iling of a first official action after the filing of a request for
continu	ued exa	mination (RCE) under 37 CFR § 1.114;
after th	ree mo	onths of the filing date of this national application or the date
of entr	y of the	e national stage in an international application, or after the
		of the first official action on the merits, whichever event last
		before the mailing date of the first to occur of either: (1) a
		nder 37 CFR §1.113; or (2) an action that otherwise closes
		the application, and:
		ned hereto is the fee set forth under 37 CFR §1.17(p) for
		ission of this Information Disclosure Statement under 37
		§ 1.97(c); OR
		icant certifies pursuant to 37 CFR § 1.97(e) that:
		each item of information contained in this Information
		Disclosure Statement was first cited in a communication
		from a foreign patent office in a counterpart foreign
		application not more than three months prior to the filing of
		this Statement; OR
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		foreign patent office in a counterpart foreign application
		and, to the knowledge of the person signing this
		certification after making reasonable inquiry, no item of
		information contained in this Statement was known to any
		individual designated under 37 CFR § 1.56(c) more than
		three months prior to the filing of this Statement;
on or	before	the payment of the issue fee but after the mailing date of the
		of either: (1) a final action under 37 CFR § 1.113; (2) a
		owance under 37 CFR § 1.311; or (3) an action that otherwise
		cution in the application, and:
	-	icant certifies pursuant to 37 CFR. § 1.97(e) that:
		each item of information contained in this Information
		Disclosure Statement was cited in a communication from a
		foreign patent office in a counterpart foreign application not
		more than three months prior to the filing of this Statement;
		or
		no item of information contained in this Information
		Disclosure Statement was cited in a communication from a

		for	reign patent office in a counterpart foreign application
		and	d, to the knowledge of the person signing this
		cer	rtification after making reasonable inquiry, no item of
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	•	thr	ree months prior to the filing of this Statement; AND
		•	ereto is the fee set forth under 37 CFR §1.17(p) for
		submissio	n of this Information Disclosure Statement under 37
		CFR.§ 1.9	7(c); OR
		after the payment	of the issue fee. Applicant requests that the information
			Information Disclosure Statement be placed in the file
			FR § 1.97(i), although the information may not be
		considered by the	•
	This a	application relies, ur	nder 35 U.S.C. § 120, on the earlier filing date of prior
	applic	cation No. APPLICA	ATION NO., filed on DATE FILED, and the references
			eferenced, but are not required to be provided in this
	applic	cation under 37 CFR	R § 1.98(d).
	Each	item of information	contained in this Information Disclosure Statement was
	cited	in a communication	from a foreign patent office in a counterpart application,
	and th	ne communication w	vas not received by any individual designated in 37 CFR
	§ 1.56	$\delta(c)$ more than thirty	days prior to the filing of this Information Disclosure
		ment. 37 CFR § 1.7	
$\triangleright$	Appli	cant submits that no	o fee is required for the consideration of this Information
	Disclo	osure Statement.	
C	Consideration	n of the listed refere	ences and favorable action are solicited.
			Respectfully submitted,
			J. ELON GRAVES et al.
			9 0 0
Dated: I	December	<b>30</b> , 2003	By: Mehaeld I
		•	Michael W. Farn, Reg. No. 41,015
			FENWICK & WEST LLP
			Silicon Valley Center 801 California Street
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	Substitute for	form 1449/	VPTO		Complete if Known	
INEC		n Die	CLOSURE	Application No.	10/688,575	
-				Filing Dat	October 16, 2003	
STATEMENT BY APPLICANT				First Named Inventor	J. Elon Graves	
				Art Unit	Not yet known	
				Examiner Name	Not yet known	
Sheet	1	of	2	Attorney Docket Number	23236-07284	

,	U.S. PATENT DOCUMENTS					
,		Document No.				
Examiner Initials*	Cite No.1	Number – Kind Code <sup>2</sup> (if known)	Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document		
		US-5,233,174 A	08-03-1993	Zmek		
		US-5,329,322 A	07-12-1994	Yancey		
		US-5,576,780 A	11-19-1996	Yancey		
		US-5,777,719 A	07-07-1998	Williams et al.		
		US-5,949,521 A	09-07-1999	Williams et al.		
		US-6,023,057 A	02-08-2000	Gaffard et al.		
		US-6,452,145 B1	09-17-2002	Graves et al.		

	FOREIGN PATENT DOCUMENTS							
		Foreign Patent Document						
Examiner Initials*	Cite No. <sup>1</sup>	Country Code <sup>3</sup> – Number <sup>4</sup> Kind Code <sup>5</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	T <sup>6</sup>			

		OTHER REFERENCES – NON-PATENT LITERATURE DOCUMENTS	
Examiner Initials*	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	T <sup>6</sup>
	1	Dreher, Andreas W. et al., "Active optical depth resolution improvement of the laser tomographic scanner," <i>Applied Optics</i> , Vol. 28, No. 4, February 15, 1989, pages 804-808.	
	2	Graves, J. Elon et al., "First Light for Hokupa'a: 36 Element Curvature AO System at UH," Proceedings of SPIE Vol. 3353, March 1998, pages 34-43.	
	3	Graves, J.E. et al., "Latest Results from the University of Hawaii Prototype Adaptive Optics System," <i>Univ. Hawaii Laser Guide Star Adaptive Optics Workshop: ProceedingsVol. 1</i> (March 10-12, 1992), pages 511-521.	
	4	Roddier, C. et al., "New optical testing methods developed at the University of Hawaii; results of ground-based telescopes and hubble space telescope," SPIE, Vol. 1531, <i>Advanced Optical Manufacturing and Testing II</i> (1991), pages 37-43.	

Examiner Signature		Date	
Signature	·	Considered	

<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609.

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<sup>&</sup>lt;sup>1</sup>Applicant's unique citation designation number (optional). <sup>2</sup>See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. <sup>3</sup>Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>4</sup>For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup>Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. <sup>6</sup>Applicant is to place a check mark here if English language Translation is attached.

PTO/SB/08A (10-01)

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Substitute for form 1449A/PTO Complet if Known Application No. 10/688,575 INFORMATION DISCLOSURE Filing Date October 16, 2003 STATEMENT BY APPLICANT **First Named Inventor** J. Elon Graves Art Unit Not yet known Examiner Name Not yet known 2 Attorney Docket Number 23236-07284 Sheet of

•		OTHER REFERENCES – NON-PATENT LITERATURE DOCUMENTS	
Examiner Initials*	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	T <sup>6</sup>
	5	Roddier, Francois et al., "A Simple Low-Order Adaptive Optics System for Near-Infrared Applications," <i>Publications of the Astronomical Society of the Pacific,</i> Vol. 103, No. 659, January 1991, pages 131-149.	
	6	Roddier, Francois, "Curvature sensing and compensation: a new concept in adaptive optics," Applied Optics, Vol. 27, No. 7, April 1, 1998, pages 1223-1225.	
	7	Roddier, Francois, "Wavefront sensing and the irradiance transport equation," <i>Applied Optics</i> , Vol. 29, No. 10, April 1, 1990, pages 1402-1403.	

Examiner Signature	·	Date Considered	

<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609.

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